

19-0028; Rev 2; 2/96



Monolithic CMOS Analog Multiplexers

General Description

Maxim's DG508A and DG509A are monolithic CMOS analog multiplexers (muxes): the DG508A is a single 8-channel (1-of-8) mux, and the DG509 is a differential 4-channel (2-of-8) mux.

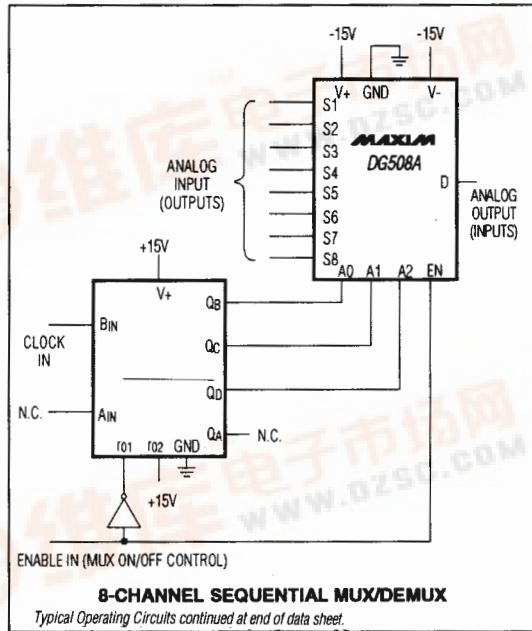
Both devices guarantee break-before-make switching. Maxim guarantees these muxes will not latch up if the power supplies are turned off with the input signals still present. Maxim also guarantees continuous operation when these devices are powered by supplies ranging from $\pm 4.5V$ to $\pm 18V$.

The DG508A/DG509A are plug-in upgrades for the industry-standard DG508A/DG509A, respectively. Maxim's parts have lower on resistance, faster enable switching times, and significantly lower leakage currents. The DG508A/DG509A also consume significantly lower power, making them ideal for portable equipment.

Applications

Control Systems
Data Logging Systems
Aircraft Heads-Up Displays
Data-Acquisition Systems
Signal Routing

Typical Operating Circuits



Features

- ◆ Improved Second Source
 - ◆ Operate from $\pm 4.5V$ to $\pm 18V$ Supplies
 - ◆ Symmetrical, Bidirectional Operation
 - ◆ Logic and Enable Inputs, TTL and CMOS Compatible
 - ◆ Latchup-Proof Construction
 - ◆ Monolithic, Low-Power CMOS Design

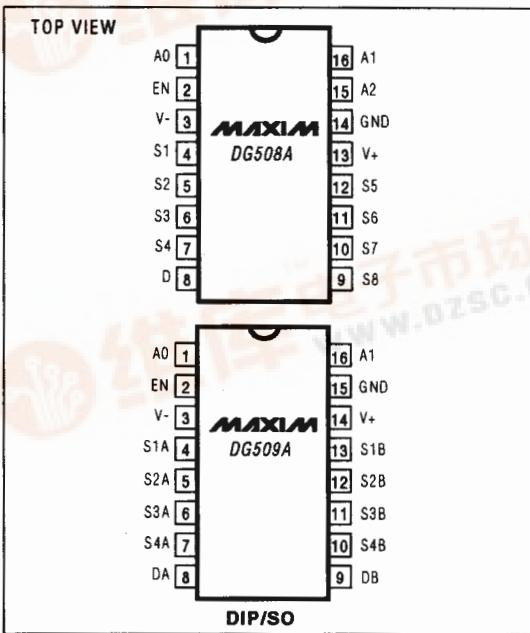
Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
DG508ACJ	0°C to +70°C	16 Plastic DIP
DG508ACWE	0°C to +70°C	16 Wide SO
DG508AC/D	0°C to +70°C	Dice*
DG508ABK	-20°C to +85°C	16 CERDIP
DG508ADJ	-40°C to +85°C	16 Plastic DIP
DG508ADY	-40°C to +85°C	16 Narrow SO
DG508AEWE	-40°C to +85°C	16 Wide SO
DG508AAK	-55°C to +125°C	16 CERDIP

Ordering Information continued at end of data sheet.

*Contact factory for dice specifications.

Pin Configurations



Monolithic CMOS Analog Multiplexers

ABSOLUTE MAXIMUM RATINGS

Voltage Referenced to V-	
V ₊	+44V
GND	+25V
Digital Inputs, V _S and V _D (Note 1)	-2V to (V ₊ + 2V) or 20mA, whichever occurs first
Current (any terminal, except S or D)	30mA
Continuous Current, S or D	20mA
Peak Current, S or D (pulsed at 1ms, 10% duty cycle max)	40mA
Continuous Power Dissipation (T _A = +70°C)	
Plastic DIP (derate 10.53mW/°C above +70°C)	842mW
Narrow SO (derate 8.70mW/°C above +70°C)	696mW
Wide SO (derate 9.52mW/°C above +70°C)	762mW
CERDIP (derate 10.00mW/°C above +70°C)	800mW

Note 1: Signals on S₊, D₊, or IN₊ exceeding V₊ or V₋ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum ratings conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(V₊ = 15V, V₋ = -15V, GND = 0V, T_A = +25°C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	DG508AA DG509AA			DG508AD/E/B/C DG509AD/E/B/C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
SWITCH									
Analog-Signal Range	V _{ANALOG}		-15	15	-15	15	-15	15	V
Drain-Source On Resistance (Note 4)	r _{D(S)}	Sequence each switch on, V _{AL} = 0.8V, V _{AH} = 2.4V	V _D = 10V, I _S = -200μA	170	300	170	350	130	350
			V _D = -10V, I _S = -200μA	130	300	130	350	130	350
Greatest Change in Drain-Source On Resistance Between Channels	Δr _{D(S)}	Δr _{D(S)} = $\left(\frac{r_{D(S)} \text{ max} - r_{D(S)} \text{ min}}{r_{D(S)}} \right)$, -10V ≤ V _S ≤ 10V		6		6		6	%
Source-Off Leakage Current	I _{S(OFF)}	V _{EN} = 0V	V _S = 10V, V _D = -10V	0.002	0.5	0.002	1	0.002	nA
			V _S = -10V, V _D = 10V	-0.5	-0.005	-1	-0.005	-1	nA
Drain-Off Leakage Current	I _{D(OFF)}	V _{EN} = 0V	V _D = 10V, V _S = -10V	0.01	2	0.01	5	0.01	nA
			V _D = -10V, V _S = 10V	-2	-0.015	-5	-0.015	-5	nA
			V _D = 10V, V _S = -10V	0.005	2	0.005	5	0.005	nA
			V _D = -10V, V _S = 10V	-2	-0.008	-5	-0.008	-5	nA
Drain-On Leakage Current	I _{D(ON)} (Note 2)	Sequence each switch on, V _{AL} = 0.8V, V _{AH} = 2.4V	V _{S(all)} = V _D = 10V	0.015	2	0.015	5	0.015	nA
			V _{S(all)} = V _D = -10V	2	-0.03	-5	-0.03	-5	nA
			V _{S(all)} = V _D = 10V	0.007	2	0.007	5	0.007	nA
			V _{S(all)} = V _D = -10V	-2	-0.015	-5	-0.015	-5	nA

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ELECTRICAL CHARACTERISTICS (continued)

(V₊ = 15V, V₋ = -15V, GND = 0V, T_A = +25°C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	DG508AA DG509AA			DG508AD/E/B/C DG509AD/E/B/C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
LOGIC INPUT									
Logic Input Current, Input Voltage High	I _{AH}	V _A = 2.4V	-10	-0.002	-10	-0.002	μA		
		V _A = 15V	0.006	10	0.006	10			
Logic Input Current, Input Voltage Low	I _{AL}	All V _A = 0V	V _{EN} = 2.4V	-10	-0.002	-10	-0.002	μA	
		V _{EN} 0V	-10	-0.002	-10	-0.002			
DYNAMIC									
Multiplexer Switching Time	t _{transition}	Figure 1	0.6	1.0	0.6	1.0	μs		
Break-Before-Make Interval	t _{open}	Figure 3	0.2		0.2		μs		
Enable Turn-On Time	t _{on(EN)}	Figure 2	0.4	1.0	0.4	1.5	μs		
Enable Turn-Off Time	t _{off(EN)}	Figure 2	0.2	0.7	0.2	1.0	μs		
Off Isolation (Note 3)	OIRR	V _{EN} = 0V, R _L = 1kΩ, C _L = 15pF, V _S = 7VRMS, f = 500kHz	68		68		dB		
Source-Off Capacitance	C _{S(off)}	V _S = 0V, V _{EN} = 0V, f = 140kHz	5		5		pF		
Drain-Off Capacitance	C _{D(off)}	V _S = 0V, V _{EN} = 0V, f = 140kHz	25		25		pF		
			12		12				
SUPPLY									
Positive Supply Current	I ₊	V _{EN} = 2.4V, all V _A = 0V or 2.4V	0.02	0.2	0.02	0.2	mA		
Negative Supply Current	I ₋	V _{EN} = 2.4V, all V _A = 0V or 2.4V	-0.1	-0.01	-0.1	-0.01	mA		
Positive Supply Current in Standby	I ₊	V _{EN} = 0V, all V _A = 0V or 2.4V	0.02	0.2	0.02	0.2	mA		
Negative Supply Current in Standby	I ₋	V _{EN} = 0V, all V _A = 0V or 2.4V	-0.1	-0.01	-0.1	-0.01	mA		
Power-Supply Range for Continuous Operation (Notes 4, 5)	V ₋ , V ₊		±4.5	±18.0	±4.5	±18.0	V		

DG508A/DG509A

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ELECTRICAL CHARACTERISTICS (continued)

(V₊ = 15V, GND = 0V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	DG508AA DG509AA			DG508AD/E/B/C DG509AD/E/B/C			UNITS	
			MIN	TYP	MAX	MIN	TYP	MAX		
SWITCH										
Analog-Signal Range	V _{ANALOG}		-15	15	-15	15			V	
Drain-Source On Resistance	R _{D(S)}	Sequence each switch on, V _{AS} = 0.8V, V _{DS} = 2.4V	V _D = 10V, I _S = -200μA	400		400	450		Ω	
			V _D = -10V, I _S = -200μA		400	450				
Source-Off Leakage Current	I _{S(OFF)}	V _{EN} = 0V	V _S = 10V, V _D = -10V	50		50			nA	
			V _S = -10V, V _D = 10V	-50		-50				
Drain-Off Leakage Current	I _{D(OFF)}	V _{EN} = 0V	V _D = 10V, V _S = -10V	200		100			nA	
			V _D = -10V, V _S = 10V	-200		-100				
	I _{D(OFF)}		V _D = 10V, V _S = -10V	100		100				
			V _D = -10V, V _S = 10V	-100		-100				
Drain-On Leakage Current	I _{D(ON)} (Note 2)	Sequence each switch on, V _{AS} = 0.8V, V _{DS} = 2.4V	V _{S(all)} = V _D = 10V	200		100			nA	
			V _{S(all)} = V _D = -10V	-200		-100				
	I _{D(ON)} (Note 2)		V _{S(all)} = V _D = 10V	100		100				
			V _{S(all)} = V _D = -10V	-100		-100				
LOGIC INPUT										
Logic Input Current, Input Voltage High	I _{AH}	V _A = 2.4V		-30		-30			μA	
		V _A = 15V			30	30				
Logic Input Current, Input Voltage Low	I _{AL}	All V _A = 0V	V _{EN} = 2.4V	-30		-30			μA	
			V _{EN} 0V	-30		-30				

Note 2: I_{D(ON)} is leakage from driver into "on" switch.

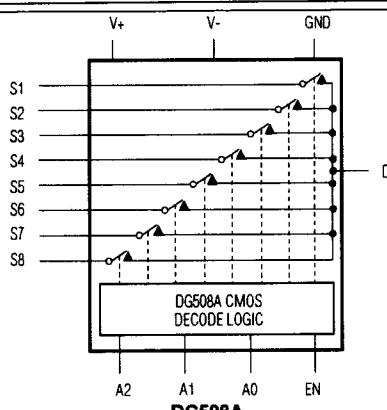
Note 3: Off isolation = $20 \log \frac{|V_S|}{|V_D|}$,

V_S = input to "off" switch,
V_D = output due to V_S.

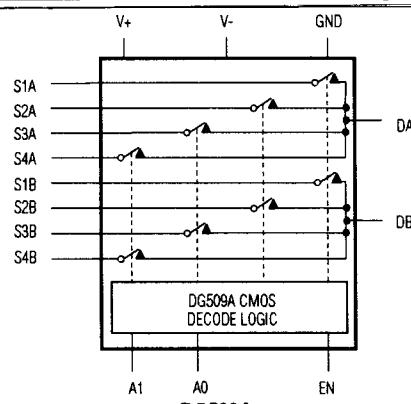
Note 4: Electrical characteristics (such as on resistance) will change when power supplies other than ±15V are used.

Note 5: For designs requiring single 5V or dual ±5V operation, refer to Maxim's improved MAX338 and MAX339. Minimum operating voltage for DG508ADY and DG509ADY is ±9V.

Functional Diagrams



DG508A
8-CHANNEL SINGLE-ENDED MULTIPLEXER



DG509A
DIFFERENTIAL 4-CHANNEL MULTIPLEXER

Monolithic CMOS Analog Multiplexers

Test Circuits/Timing Diagrams

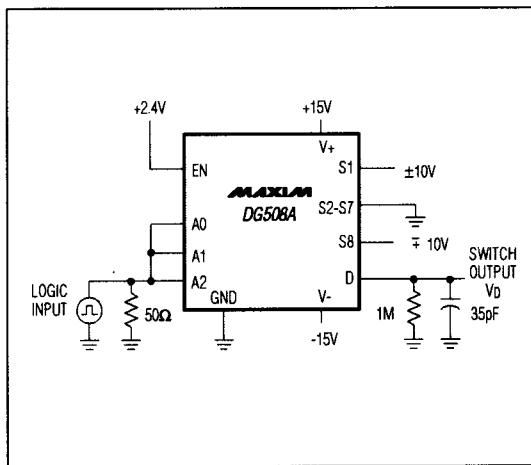


Figure 1a. Switching-Time Test Circuit

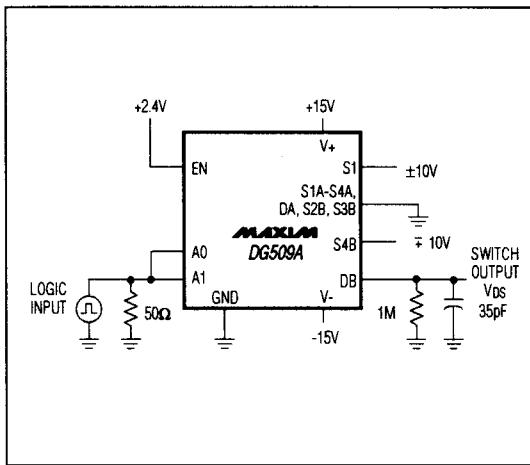


Figure 1b. Switching-Time Test Circuit

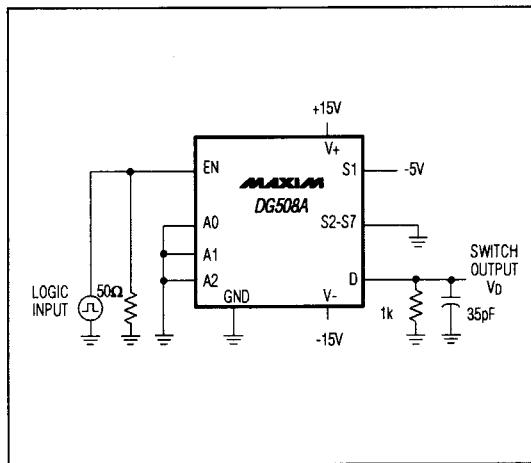


Figure 2a. DG509A Enable-Time Test Circuit

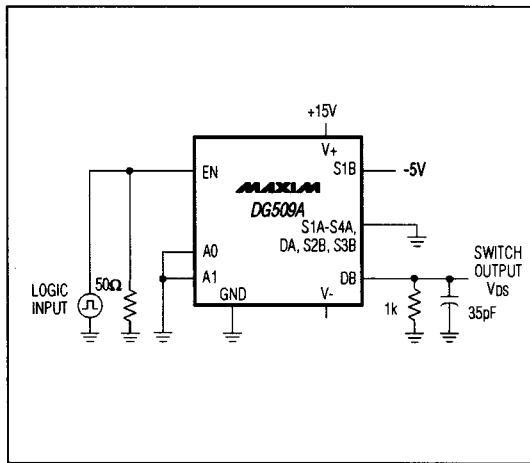


Figure 2b. DG509A Enable-Time Test Circuit

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Test Circuits/Timing Diagrams (continued)

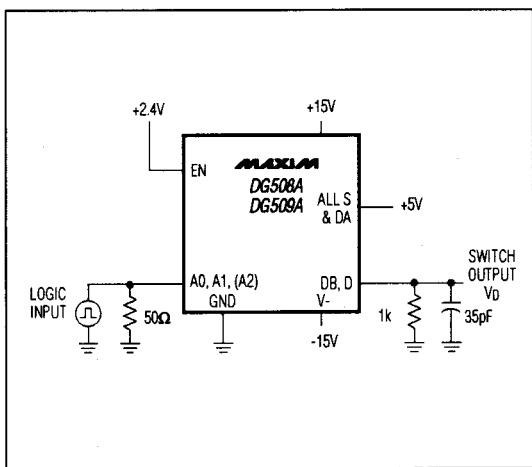


Figure 3. Break-Before-Make Test Circuit

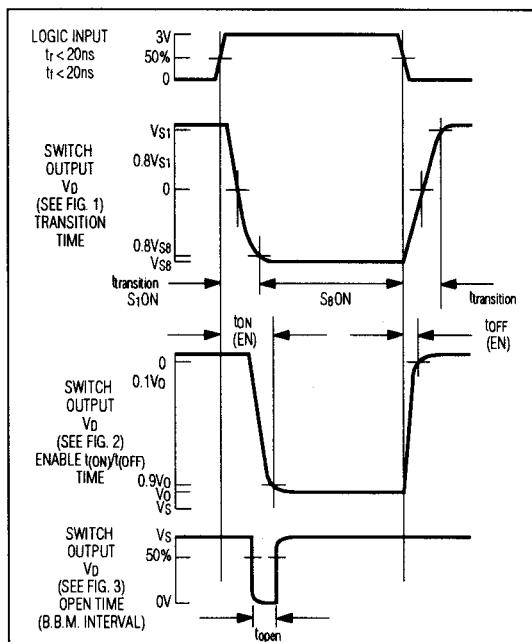


Figure 4. Timing Diagram for Figures 1, 2, and 3

Table 1a. DG508A Truth Table

A2	A1	A0	EN	ON SWITCH
X	X	X	0	NONE
0	0	0	1	1
0	0	1	1	2
0	1	0	1	3
0	1	1	1	4
1	0	0	1	5
1	0	1	1	6
1	1	0	1	7
1	1	1	1	8

X = Don't Care

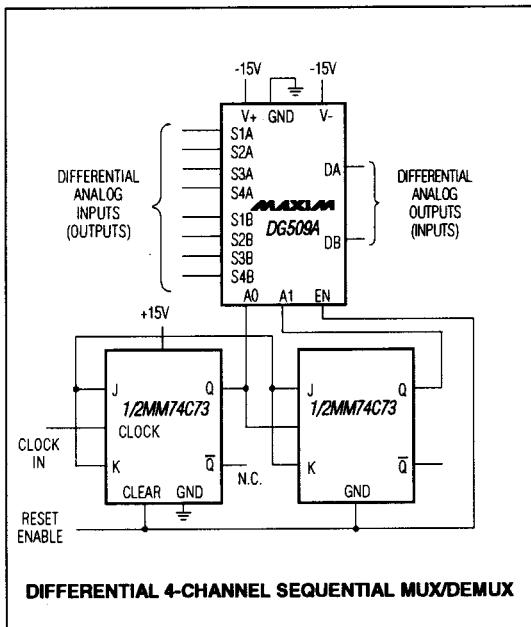
Table 1b. DG509A Truth Table

A1	A0	EN	ON SWITCH
X	X	0	NONE
0	0	1	1
0	1	1	2
1	0	1	3
1	1	1	4

X = Don't Care

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Typical Operating Circuits (continued)



Ordering Information (continued)

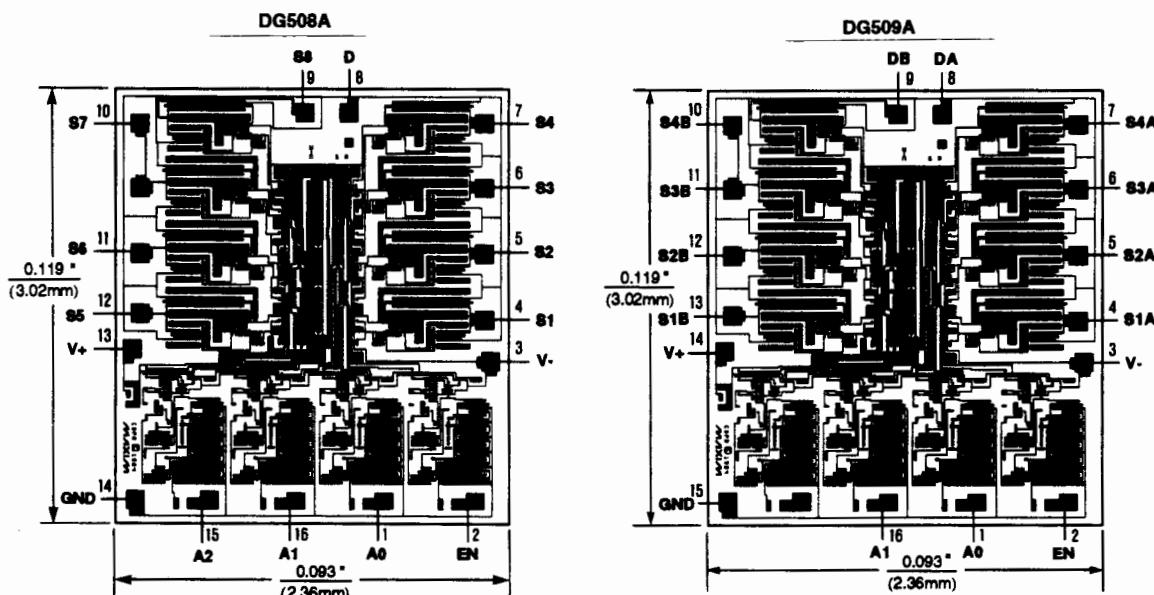
PART	TEMP. RANGE	PIN-PACKAGE
DG509ACJ	0°C to +70°C	16 Plastic DIP
DG509ACWE	0°C to +70°C	16 Wide SO
DG509AC/D	0°C to +70°C	Dice*
DG509ABK	-20°C to +85°C	16 CERDIP
DG509ADJ	-40°C to +85°C	16 Plastic DIP
DG509ADY	-40°C to +85°C	16 Narrow SO
DG509AEWE	-40°C to +85°C	16 Wide SO
DG509AAK	-55°C to +125°C	16 CERDIP

*Contact factory for dice specifications.

Monolithic CMOS Analog Multiplexers

DG508A/DG509A

Chip Topographies



Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

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